



General Description

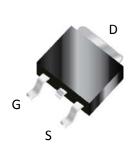
These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

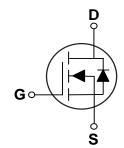
BV _{DSS}	R _{DS(ON)}	I _D
100 V	3.5 mΩ	190 A

Features

- $\cdot R_{DS(ON)} \le 3.5 m \Omega @V_{GS} = 10V$
- · Improved dv/dt capability
- · Fast switching
- · Green Device Available

TO-263 Pin Configuration





Applications

- Networking
- · Load Switch
- LED applications
- · Quick Charger

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	100	V
V_{GS}	Gate-Source Voltage	±20	V
1	Drain Current - Continuous (T _C =25°C)	190	Α
I _D	Drain Current - Continuous (T _C =100°C)	120	7 ^
I _{DM}	Drain Current - Pulsed (NOTE 1)	840	Α
E _{AS}	Single Pulse Avalanche Energy (NOTE 2)	280	mJ
I _{AS}	Single Pulse Avalanche Current (NOTE 2)	75	Α
P_{D}	Power Dissipation (T _C =25°C)	463	W
ı D	Power Dissipation - Derate above 25°C	3.7	W/°C
T _J	Operating Junction Temperature Range	-50 to 150	°C
T _{STG}	Storage Temperature Range	-50 to 150	°C
Marking Code		NM3P5	

Thermal Characteristics					
Symbol	Parameter	Тур.	Max.	Unit	
$R_{\theta JA}$	Thermal Resistance Junction to Ambient		62	°C/W	
$R_{ heta JC}$	Thermal Resistance Junction to Case		0.27	°C/W	





Electrical Characteristics (T_J=25°C, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	100			V
I _{DSS}	Drain-Source Leakage Current	V_{DS} =100V , V_{GS} =0V , T_J =25°C		-	1	uA
	Dialii-Source Leakage Current	V _{DS} =80V , V _{GS} =0V , T _J =125°C			10	uA
I_{GSS}	Gate-Source Leakage Current	V_{GS} =±20V , V_{DS} =0V			±100	nA

On Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V , I _D =20A		3	3.5	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}$, $I_D=250uA$	1.5	2.5	3.5	V
gfs	Forward Transconductance	V_{DS} =10V , I_{D} =3A		15		S

Dynamic and switching Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Q_g	Total Gate Charge	\/ -90\/ \/ -10\/ -10A		295	450	
Q_{gs}	Gate-Source Charge	V_{DS} =80V , V_{GS} =10V , I_{D} =10A (NOTE 3 \ 4)		70	140	nC
Q_{gd}	Gate-Drain Charge	(NOTE 3 · 4)		75	150	
$T_{d(on)}$	Turn-On Delay Time	V -50V V -40V D -60		66.2	120	
T_r	Rise Time	V_{DD} =50V , V_{GS} =10V , R_{G} =6 Ω , I_{D} =1A (NOTE 3 \ 4)		79.6	160	nS
$T_{d(off)}$	Turn-Off Delay Time			242	480	113
T_f	Fall Time			103	200	
C _{iss}	Input Capacitance			19000	38000	
C_{oss}	Output Capacitance	V_{DS} =50V , V_{GS} =0V , f=1MHz		680	1360	pF
C_{rss}	Reverse Transfer Capacitance			270	540	
R_g	Gate Resistance	V_{DS} =0V , V_{GS} =0V , f=1MHz		1.8	3.6	Ω

Drain-Source Diode Characteristics and Ratings

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
I _S	Continuous Source Current	V _G =V _D =0V , Force Current			190	Α
I _{SM}	Pulsed Source Current	V _G =V _D =0V, Force Current			380	Α
V_{SD}	Diode Forward Voltage	V_{GS} =0V , I_{S} =1A , T_{J} =25 $^{\circ}$ C			1	V
trr	Reverse Recovery Time	V_{GS} =0V , I_{S} =10A , di/dt=100A/ μ s		64		nS
Qrr	Reverse Recovery Charge	, T _J =25°C		150		nC

NOTES:

- 1. Repetitive Rating: Pulsed width limited by maximum junction temperature.
- 2. V_{DD} =50V, V_{GS} =10V, L=0.1mH, I_{AS} =75A, R_{G} =25 Ω , Starting T_{J} =25 $^{\circ}$ C.
- 3. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.
- 4. Essentially independent of operating temperature.





Characteristics Curves

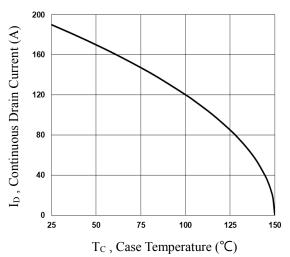


Fig.1 Continuous Drain Current vs. Tc

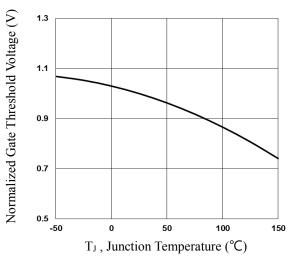


Fig.3 Normalized Vth vs. T_J

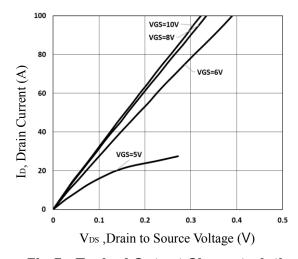


Fig.5 Typical Output Characteristics

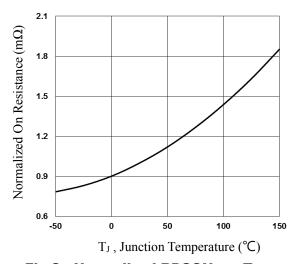


Fig.2 Normalized RDSON vs. TJ

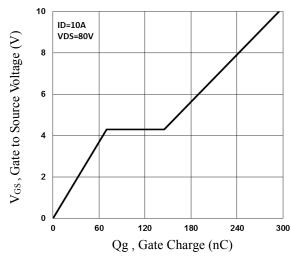


Fig.4 Gate Charge Characteristics

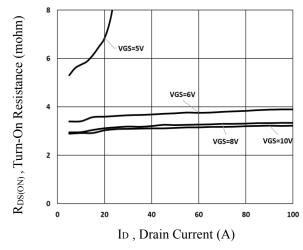


Fig.6 Turn-On Resistance vs. ID





Characteristics Curves

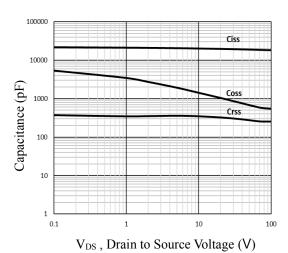


Fig.7 Capacitance Characteristics

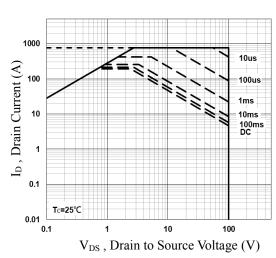


Fig.8 Maximum Safe Operation Area

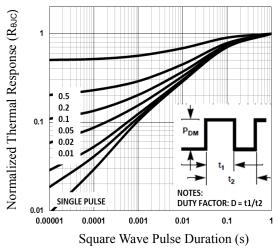


Fig.9 Normalized Transient Impedance

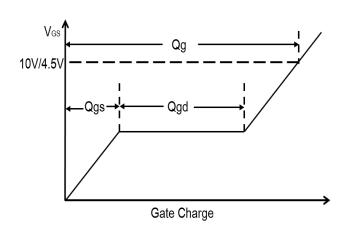


Fig.10 Gate Charge Waveform

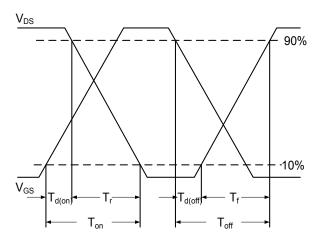
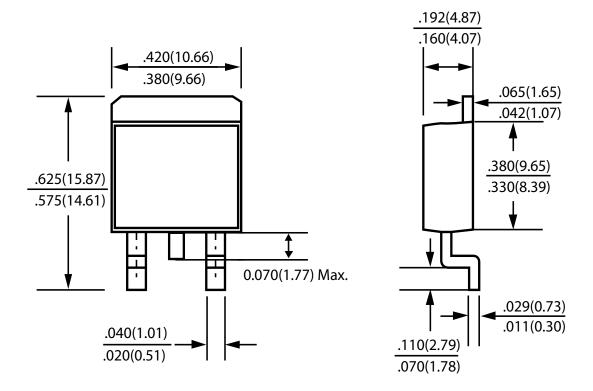


Fig.11 Switching Time Waveform





Package Outline Dimensions



TO-263Dimensions in inches and (millimeters)





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